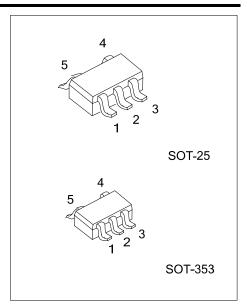
# SINGLE BUFFER GATE

#### ■ DESCRIPTION

The **U74LVC1G34** is a single buffer, it provides the function Y = A. This device has power-down protective circuit, preventing device destruction when it is powered down.

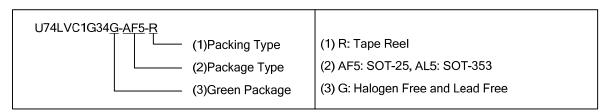
#### **■** FEATURES

- \* Operate From 1.65V to 5.5V
- \* Inputs Accept Voltages to 5.5V
- \* I<sub>OFF</sub> Supports Partial-Power-Down Mode
- \* Low Power Dissipation
- \* Max  $t_{PD}$  of 3.5 ns at 3.3V

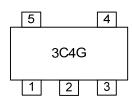


#### ORDERING INFORMATION

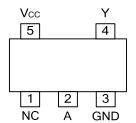
Ordering Number	Package	Packing
U74LVC1G34G-AF5-R	SOT-25	Tape Reel
U74LVC1G34G-AL5-R	SOT-353	Tape Reel



#### ■ MARKING



### ■ PIN CONFIGURATION



### ■ FUNCTION TABLE

INPUT(A)	OUTPUT(Y)
Н	Н
L	L

Note: H: HIGH voltage level; L: LOW voltage level.

## ■ LOGIC DIAGRAM (Positive Logic)



Logic Symbol

IEC Logic Symbol

### ■ ABSOLUTE MAXIMUM RATING (T<sub>A</sub> =25°C, unless otherwise specified)

	PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage		V <sub>CC</sub>	-0.5 ~ +6.5	V
Input Voltage		V <sub>IN</sub>	-0.5 ~ +6.5	V
Output in the high or low state			-0.5 ~ V <sub>CC</sub> +0.5	V
Output Voltage Output in the high-impedance or power-off state		V <sub>OUT</sub>	-0.5 ~ +6.5	V
V <sub>CC</sub> or GND Curr	ent	I <sub>CC</sub>	±100	mA
Continuous Output Current (V <sub>OUT</sub> =0 to V <sub>CC)</sub>		I <sub>OUT</sub>	±50	mA
Input Clamp Current (V <sub>IN</sub> <0)		I <sub>IK</sub>	-50	mA
Output Clamp Current (V <sub>OUT</sub> <0)		I <sub>OK</sub>	-50	mA
Operating Temperature		T <sub>OPR</sub>	-40 ~ +85	°C
Storage Tempera	ature Range	T <sub>STG</sub>	-65 ~ +150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

### ■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT	
	SOT-25	0	230	90 AA	
Junctions to Ambient	SOT-353	θ <sub>JA</sub>	350	°C/W	

#### RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Cumply Voltage		Operating	1.65		5.5	V
Supply Voltage	V <sub>CC</sub>	Data retention only	1.5			V
Input Voltage	$V_{IN}$		0		5.5	V
Output Voltage	$V_{OUT}$	High or low state	0		$V_{CC}$	٧
		V <sub>CC</sub> =1.65V			-4	mA
		V <sub>CC</sub> =2.3V			-8	mA
High-Level Output Current	I <sub>OH</sub>	V <sub>CC</sub> =3V			-16	mA
		V <sub>CC</sub> =3V			-24	mA
		V <sub>CC</sub> =4.5V			-32	mA
	I <sub>OL</sub>	V <sub>CC</sub> =1.65V			4	mA
		V <sub>CC</sub> =2.3V			8	mA
Low-Level Output Current		V <sub>CC</sub> =3V			16	mA
		V <sub>CC</sub> =3V			24	mA
		V <sub>CC</sub> =4.5V			32	mA
	t <sub>R</sub> / t <sub>F</sub>	V <sub>CC</sub> =1.8V±0.15V, 2.5V±0.2V			20	ns/V
Input Transition Rise or Fall Rate		V <sub>CC</sub> =3.3V±0.3V			10	ns/V
		V <sub>CC</sub> =5V±0.5V			10	ns/V

### ■ ELECTRICAL CHARACTERISTICS (T<sub>A</sub> =25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST	CONDITIONS	MIN	TYP	MAX	UNIT
		V <sub>CC</sub> =1.65V ~ 1.95V		0.65*V <sub>CC</sub>			V
High Loyal Input Valtage	V	V <sub>CC</sub> =2.3V ~ 2	V <sub>CC</sub> =2.3V ~ 2.7V				V
High-Level Input Voltage	$V_{IH}$	$V_{CC} = 3V \sim 3.6$	V	2			V
		V <sub>CC</sub> =4.5V ~ 5	.5V	0.7*V <sub>CC</sub>			V
		V <sub>CC</sub> =1.65V ~	1.95V			0.35*V <sub>CC</sub>	V
Low Lovel Input Voltage	$V_{IL}$	V <sub>CC</sub> =2.3V ~ 2	.7V			0.7	V
Low-Level Input Voltage	VIL	$V_{CC} = 3V \sim 3.6$	V			0.8	V
		V <sub>CC</sub> =4.5V ~ 5	.5V			0.3*V <sub>CC</sub>	V
		I <sub>OH</sub> =-100μA	V <sub>CC</sub> =1.65 ~ 5.5V	V <sub>CC</sub> -0.1			V
		I <sub>OH</sub> =-4mA	V <sub>CC</sub> =1.65V	1.2			V
High-Level Output Voltage	\/	I <sub>OH</sub> =-8mA	V <sub>CC</sub> =2.3V	1.9			V
	V <sub>OH</sub>	I <sub>OH</sub> =-16mA	V <sub>CC</sub> =3.0V	2.4			V
		I <sub>OH</sub> =-24mA	V <sub>CC</sub> =3.0V	2.3			V
		I <sub>OH</sub> =-32mA	V <sub>CC</sub> =4.5V	3.8			V
	V <sub>OL</sub>	I <sub>OL</sub> =100μA	V <sub>CC</sub> =1.65 ~ 5.5V			0.1	V
		I <sub>OL</sub> =4mA	V <sub>CC</sub> =1.65V			0.45	V
Low-Level Output Voltage		I <sub>OL</sub> =8mA	V <sub>CC</sub> =2.3V			0.3	V
Low-Level Output Voltage		I <sub>OL</sub> =16mA	V <sub>CC</sub> =3.0V			0.4	V
		I <sub>OL</sub> =24mA	V <sub>CC</sub> =3.0V			0.55	V
	l	I <sub>OL</sub> =32mA	V <sub>CC</sub> =4.5V			0.55	V
Input Leakage Current	$I_{I(LEAK)}$	$V_{IN}$ =5.5V or GND, $V_{CC}$ =0 ~ 5.5V				±1	μA
Power OFF Leakage Current	I <sub>OFF</sub>	V <sub>IN</sub> or V <sub>OUT</sub> =5.5V, V <sub>CC</sub> =0V				±10	μΑ
Quiescent Supply Current	ΙQ	V <sub>IN</sub> =5.5V or GND, I <sub>OUT</sub> =0				10	μA
	iQ	V <sub>CC</sub> =1.65 ~ 5.5V				10	μΛ
Additional Quiescent Supply	$\Delta I_Q$	$V_{CC}$ =3 ~ 5.5V, One input at $V_{CC}$ -0.6V,				500	μA
Current Per Input Pin		Other inputs a				500	
Input Capacitance	$C_{IN}$	$V_{CC}$ =3.3V, $V_{IN}$	=V <sub>CC</sub> or GND		3.5		pF

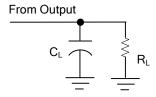
## ■ SWITCHING CHARACTERISTICS (T<sub>A</sub>=25°C)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
		V <sub>CC</sub> =1.8±0.15V		2		9.9	ns
Propagation delay from input	t <sub>PLH</sub> / t <sub>PHL</sub>	V <sub>CC</sub> =2.5±0.2V	C <sub>L</sub> =15pF,	1.5		6	ns
(A) to output(Y)		V <sub>CC</sub> =3.3±0.3V	$R_L=1M\Omega$	1		3.5	ns
		V <sub>CC</sub> =5±0.5V		1		2.9	ns
		$V_{CC}$ =1.8±0.15V, $R_L$ =1K $\Omega$	0 00-5	3.2		8.6	ns
Propagation delay from input (A) to output(Y)		$V_{CC}$ =2.5±0.2V, $R_L$ =500 $\Omega$	C <sub>L</sub> =30pF	1.5		4.4	ns
	t <sub>PLH</sub> / t <sub>PHL</sub>	V <sub>CC</sub> =3.3±0.3V	C <sub>L</sub> =50pF,	1.5		4.1	ns
		V <sub>CC</sub> =5±0.5V	R <sub>L</sub> =500Ω	1		3.2	ns

# ■ OPERATING CHARACTERISTICS (T<sub>A</sub>=25°C)

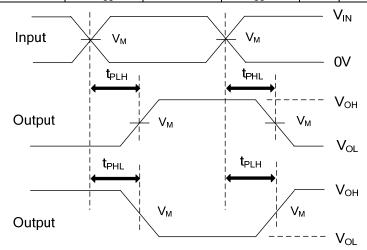
PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
Power Dissipation Capacitance		V <sub>CC</sub> =1.8V			16		pF
	$C_PD$	V <sub>CC</sub> =2.5V	£ 40MII		16		pF
		V <sub>CC</sub> =3.3V	f=10MH <sub>Z</sub>		16		pF
			V <sub>CC</sub> =5V			18	

### ■ TEST CIRCUIT AND WAVEFORMS



**TEST CIRCUIT** 

	INP	UTS	V	0	ם
V <sub>CC</sub>	$V_{IN}$	t <sub>R</sub> , t <sub>F</sub>	$V_{M}$	$C_L$	$R_L$
1.8V±0.15V	V <sub>CC</sub>	≤2ns	V <sub>CC</sub> /2	15pF	1ΜΩ
2.5V±0.2V	V <sub>CC</sub>	≤2ns	V <sub>CC</sub> /2	15pF	1ΜΩ
3.3V±0.3V	3V	≤2.5ns	1.5V	15pF	1ΜΩ
5V±0.5V	$V_{CC}$	≤2.5ns	V <sub>CC</sub> /2	15pF	1ΜΩ

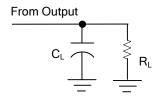


PROPAGATION DELAY TIMES

Note:  $C_L$  includes probe and jig capacitance.

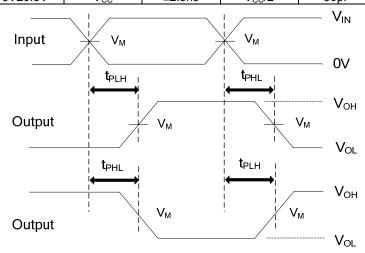
All input pulses are supplied by generators having the following characteristics:  $P_{RR} \le 10 MHz$ ,  $Z_0 = 50 \Omega$ .

#### TEST CIRCUIT AND WAVEFORMS(Cont.)



**TEST CIRCUIT** 

	INP	INPUTS			Б
V <sub>cc</sub>	V <sub>IN</sub>	t <sub>R</sub> , t <sub>F</sub>	$V_{M}$	C <sub>L</sub>	$R_L$
1.8V±0.15V	V <sub>CC</sub>	≤2ns	V <sub>CC</sub> /2	30pF	1ΚΩ
2.5V±0.2V	V <sub>CC</sub>	≤2ns	V <sub>CC</sub> /2	30pF	500Ω
3.3V±0.3V	3V	≤2.5ns	1.5V	50pF	500Ω
5V±0.5V	Vcc	≤2.5ns	Vcc/2	50pF	500Ω



PROPAGATION DELAY TIMES

Note: C<sub>L</sub> includes probe and jig capacitance.

All input pulses are supplied by generators having the following characteristics:  $P_{RR} \le 10 \text{MHz}$ ,  $Z_0 = 50 \Omega$ .

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